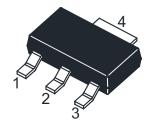
WTQ06P2K0L-AH

P-Channel Enhancement Mode Power MOSFET

Features

- AEC-Q101 Qualified
- · Surface-mounted package
- Halogen and Antimony Free(HAF), RoHS compliant

Gate Source



1.Gate 2.Drain 3.Source 4.Drain SOT-223 Plastic Package

Applications

- · High speed Switching
- Portable appliances
- · Battery management
- DC-DC converters for Telecom and Computer

Key Parameters

Parameter	Value	Unit
-BV _{DSS}	60	V
D May	200 @ -V _{GS} = 10 V	mΩ
R _{DS(ON)} Max	300 @ -V _{GS} = 4.5 V	mΩ
-V _{GS(th)} typ	1.8	V
Q _g typ	9 @ -V _{GS} = 10 V	nC

Absolute Maximum Ratings (at Ta = 25°C unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	-V _{DS}	60	V
Gate-Source Voltage	V _{GS}	± 20	V
Drain Current $T_a = 25^{\circ}C$ $T_a = 100^{\circ}C$	-I _D	3 2	А
Peak Drain Current, Pulsed 1)	-I _{DM}	12	Α
Power Dissipation	P _D	1.25	W
Single-Pulse Avalanche Current	-l _{AS}	12	А
Single-Pulse Avalanche Energy 2)	E _{AS}	7.2	mJ
Operating Junction and Storage Temperature Range	Tj, Tstg	- 55 to + 150	°C

Thermal Characteristics

Parameter	Symbol	Max.	Unit	
Thermal Resistance-Junction to Ambient 3)	t < 10 s	D	60	°C/W
Thermal Resistance-Junction to Ambient 3)	Steady State	$R_{ heta JA}$	100	°C/W

¹⁾ Pulse Test: Pulse Width ≤ 100 μs, Duty Cycle ≤ 2%, Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}$ = 150°C.



²⁾ Limited by $T_{J(MAX)}$, starting T_J = 25 °C, L = 0.1 mH, R_g = 25 Ω , $-I_D$ = 12 A, V_{GS} = 10 V.

³⁾ Device mounted on FR-4 substrate PC board, 2oz copper, with 1-inch square copper plate in still air.

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Characteristics at T_a = 25°C unless otherwise specified

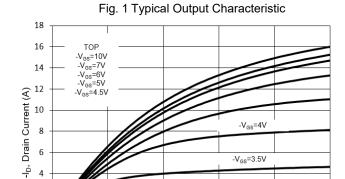
Parameter	Symbol	Min.	Тур.	Max.	Unit
STATIC PARAMETERS					
Drain-Source Breakdown Voltage at -I _D = 250 μA	-V _{(BR)DSS}	60	-	-	V
Zero Gate Voltage Drain Current at -V _{DS} = 48 V	-l _{DSS}	-	-	1	μΑ
Gate-Source Leakage at V _{GS} = ± 20 V	lgss	-	-	± 100	nA
Gate-Source Threshold Voltage at $V_{DS} = V_{GS}$, $-I_D = 250 \mu A$	-V _{GS(th)}	1	-	3	V
Drain-Source On-State Resistance at $-V_{GS} = 10 \text{ V}$, $-I_D = 3 \text{ A}$ at $-V_{GS} = 4.5 \text{ V}$, $-I_D = 2 \text{ A}$	R _{DS(on)}	-	155 -	200 300	mΩ
DYNAMIC PARAMETERS					
Gate Resistance at $-V_{DS} = 0$, $V_{GS} = 0$, $f = 1$ MHz	R _g	-	18	-	Ω
Input Capacitance at $-V_{DS} = 30 \text{ V}$, $V_{GS} = 0 \text{ V}$, $f = 1 \text{ MHz}$	C _{iss}	-	589	-	pF
Output Capacitance at $-V_{DS} = 30 \text{ V}$, $V_{GS} = 0 \text{ V}$, $f = 1 \text{ MHz}$	Coss	-	35	-	pF
Reverse Transfer Capacitance at $-V_{DS} = 30 \text{ V}$, $V_{GS} = 0 \text{ V}$, $f = 1 \text{ MHz}$	C _{rss}	-	8	-	pF
Total Gate Charge at $-V_{DS} = 20 \text{ V}$, $-V_{GS} = 10 \text{ V}$, $-I_{D} = 1.5 \text{ A}$	Q_g	-	9	-	nC
Gate-Source Charge at $-V_{DS} = 20 \text{ V}$, $-V_{GS} = 10 \text{ V}$, $-I_D = 1.5 \text{ A}$	Q _{gs}	-	2	-	nC
Gate-Drain Charge at $-V_{DS} = 20 \text{ V}$, $-V_{GS} = 10 \text{ V}$, $-I_D = 1.5 \text{ A}$	Q _{gd}	-	1.3	-	nC
Turn-On Delay Time at $-V_{DD}$ = 15 V, $-V_{GS}$ = 10 V, $-I_D$ = 1 A, R_g = 24 Ω	t _{d(on)}	-	18	-	ns
Turn-On Rise Time at -V _{DD} = 15 V, -V _{GS} = 10 V, -I _D = 1 A, R_g = 24 Ω	t r	-	14	-	ns
Turn-Off Delay Time at -V _{DD} = 15 V, -V _{GS} = 10 V, -I _D = 1 A, R_g = 24 Ω	t _{d(off)}	-	28	-	ns
Turn-Off Fall Time at -V _{DD} = 15 V, -V _{GS} = 10 V, -I _D = 1 A, R _g = 24 Ω	t _f	-	7	-	ns
Body-Diode PARAMETERS					
Body Diode Voltage at -l _s = 1 A	-V _{SD}	-	-	1	V
Body-Diode Continuous Current	-ls	-	-	3	Α
Body-Diode Continuous Current, Pulsed	-I _{SM}	-	-	12	Α
Body Diode Reverse Recovery Time at -ls = 1.5 A, di/dt = 100 A / µs	t _{rr}	-	12.4	-	ns
Body Diode Reverse Recovery Charge at -I _s = 1.5 A, di/dt = 100 A / µs	Qrr	-	8	-	nC



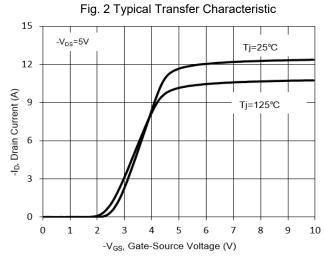
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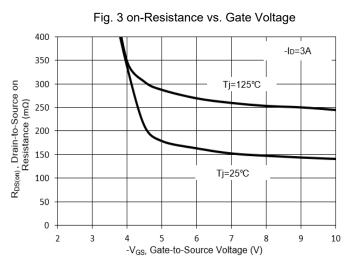
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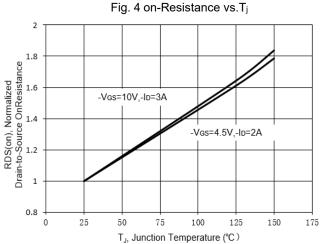
Electrical Characteristics Curves

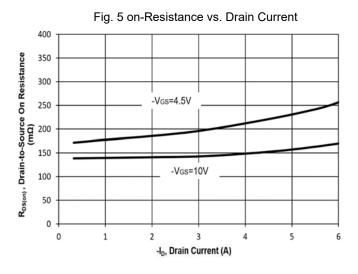


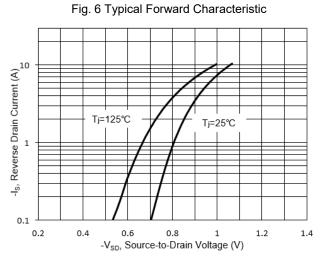
-V_{DS}, Drain-to-Source Voltage (V)



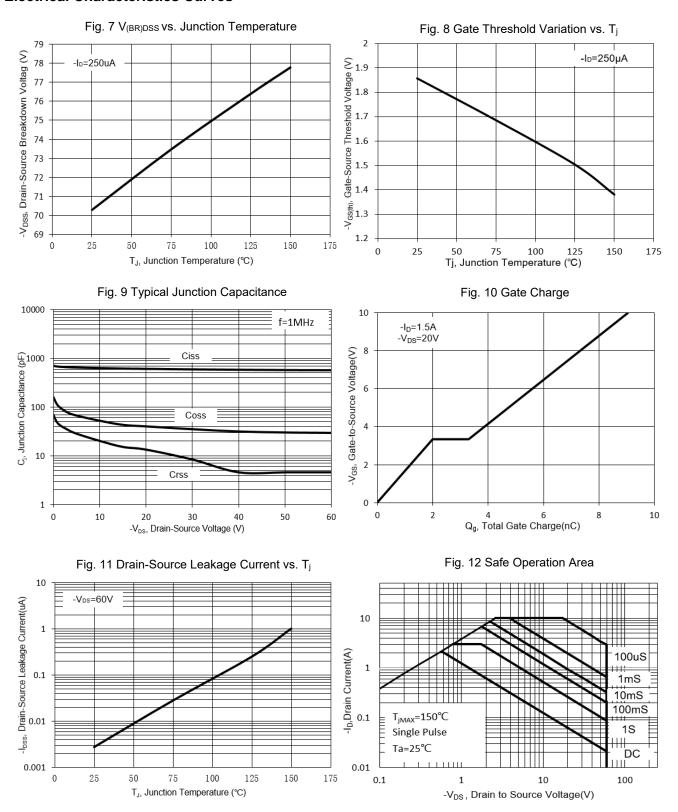








Electrical Characteristics Curves





Electrical Characteristics Curves

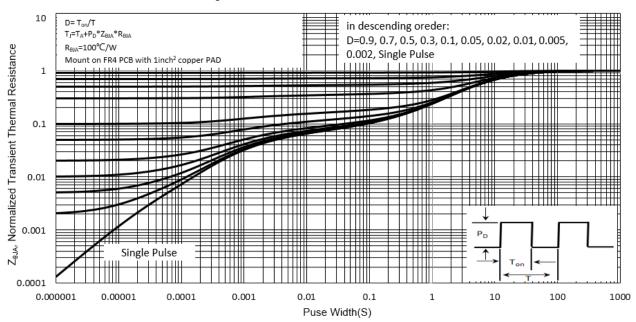


Fig. 13 Transient Thermal Resistance $(Z_{\theta JA})$



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Test Circuits

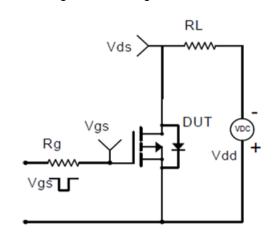


Fig.1-1 Switching times test circuit

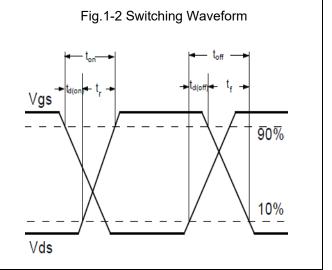


Fig.2-1 Gate charge test circuit

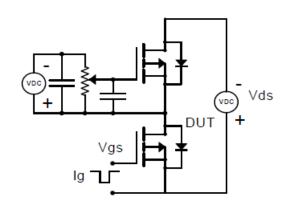


Fig.2-2 Gate charge waveform

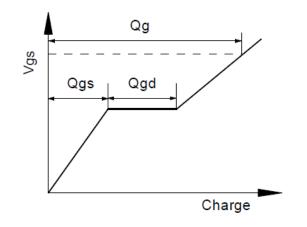


Fig.3-1 Avalanche test circuit

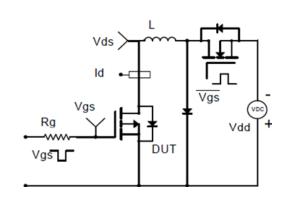
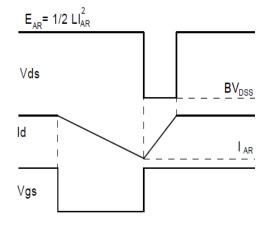


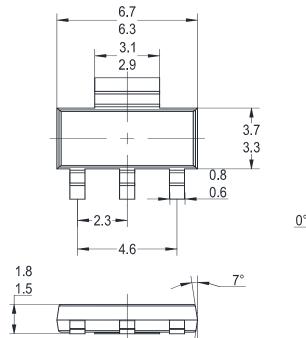
Fig.3-2 Avalanche waveform

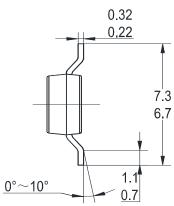


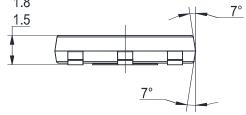


Package Outline (Dimensions in mm)

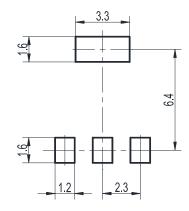
SOT-223







Recommended Soldering Footprint



Packing information

- 7		9					
	Package Tape Width (mm)	Tape Width	Pit	tch	Reel	Size	Por Pool Pooking Quantity
		mm	inch	mm	inch	Per Reel Packing Quantity	
	SOT-223	12	8 ± 0.1	0.315 ± 0.004	330	13	3,000

Marking information

" TQ06P2K0L " = Part No.

" ***** " = Date Code Marking

Font type: Arial





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